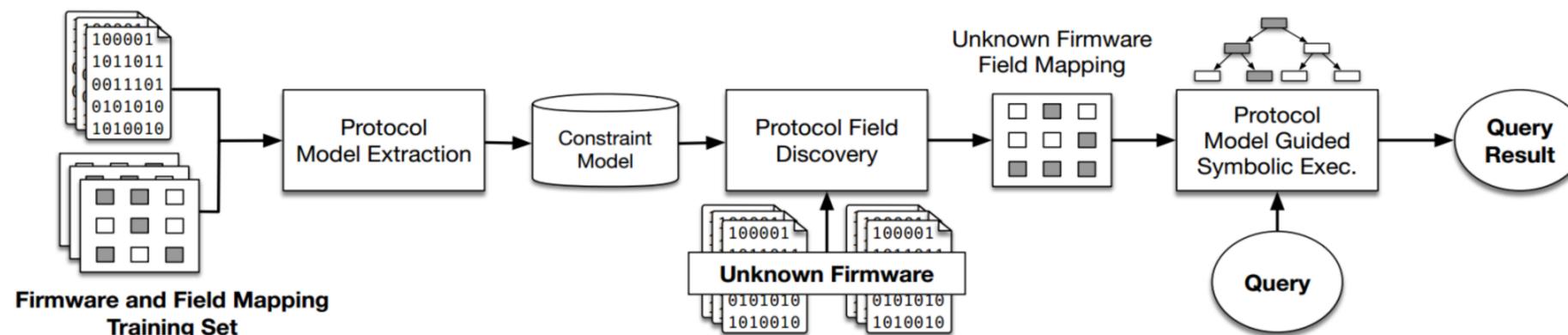


ProXray: Protocol Model Learning and Guided Firmware Analysis

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<https://firmware-analysis.org/>



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Problem Description

The number of Internet of Things (IoT) devices has reached 7 billion globally in 2018. Knowing whether these devices are safe and secure to use is becoming critical. IoT devices usually implement communication protocols such as USB and Bluetooth within firmware.

- Scalability issues in automated analysis of firmware.
- A lack of formal specifications of the protocols .
- Significant manual effort needed to reverse engineer the device firmware.

Approach

- Use symbolic execution to extract the protocol models and to perform guided analysis
- Constraints of the model are semantically checked against the constraints explored in the unknown firmware for reverse engineering

Broader Impact

- Improving security of peripheral devices by vetting how they utilize the underlying communication protocols that are not necessarily designed with security in mind.
- Reducing the attack surface of the IoT landscape by detecting vulnerabilities in the protocol stack implementations.
- Speedup in reaching protocol relevant targets during firmware analysis
 - up to 73.8 times speedup for USB firmware and at least an order of magnitude speedup for Bluetooth firmware
- Improved coverage of reaching protocol relevant parts of firmware during extraction
- Utilization of formal methods in embedded system security is demonstrated in PI Butler's Embedded Security course and Co-PI Yavuz's Automated HW/SW Verification course
- Public release of automatically generated protocol models

Scientific Impact

Automatically extracting and learning formal models of protocols can support automated reverse engineering and automated test generation.

Project Title: Domain Informed Techniques for Detecting and Defending Against Malicious Firmware

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